DELIVERY SPECIFICATION SPEC. No. A-High-h D A T E : Oct., 2021 То **Non-Controlled Copy** CUSTOMER'S PRODUCT NAME TDK'S PRODUCT NAME **Multilayer Ceramic Chip Capacitors High Voltage Series** Bulk and Tape packaging [RoHS compliant] CGA6,CGA7,CGA8,CGA9 Type C0G,X7R Characteristics Please return this specification to TDK representatives with your signature. If orders are placed without returned specification, please allow us to judge that specification is accepted by your side. **RECEIPT CONFIRMATION** DATE: YEAR MONTH DAY Test conditions in this specification based on AEC-Q200 for automotive application. **TDK** Corporation Sales Engineering Electronic Components Electronic Components Business Company Ceramic Capacitors Business Group Sales & Marketing Group

APPROVED	Person in charge	APPROVED	CHECKED	Person in charge

SCOPE

This delivery specification shall be applied to Multilayer ceramic chip capacitors to be delivered to

PRODUCTION PLACES

Production places defined in this specification shall be TDK Corporation, TDK(Suzhou)Co.,Ltd and TDK Components U.S.A., Inc.

PRODUCT NAME

The name of the product to be defined in this specifications shall be CGA $OOO \Delta \Box \Box \Box \simeq X$.

REFERENCE STANDARD

JIS C 5101-1:2010	Fixed capacitors for use in electronic equipment-Part 1: Generic specification
C 5101-21 : 2014	Fixed capacitors for use in electronic equipment-Part21 : Sectional specification
	: Fixed surface mount multilayer capacitors of ceramic dielectric, Class1
C 5101-22 : 2014	Fixed capacitors for use in electronic equipment-Part22 : Sectional specification
	: Fixed surface mount multilayer capacitors of ceramic dielectric, Class 2
C 0806-3 : 2014	Packaging of components for automatic handling - Part 3: Packaging of
	surface mount components on continuous tapes
JEITA RCR-2335 C 2014	Safety application guide for fixed ceramic capacitors for use in electronic
	equipment

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- **10. RECOMMENDATION**

<EXPLANATORY NOTE>

When the mistrust in the spec arises, this specification is given priority. And it will be confirmed by written spec change after conference of both posts involved.

This specification warrants the quality of the ceramic chip capacitor. Capacitors should be evaluated or confirmed a state of mounted on your product.

If the use of the capacitors goes beyond the bounds of this specification, we can not afford to guarantee.

Division	Date	SPEC. No.	
Ceramic Capacitors Business Group	October, 2021	A-High-h	

- 11. SOLDERING CONDITION
- 13. TAPE PACKAGING SPECIFICATION

1. CODE CONSTRUCTION

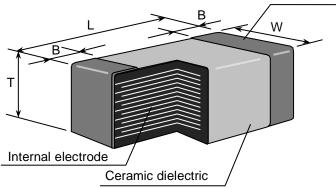
(Example)	CGA <u>CGA</u> (1)	6 <u>8</u> (2)		3 A <u>3 D</u> (6)		J <u>M</u> (8)	T <u>T</u> (9)	0000 <u>0000</u> (10)	
(1) Series					Sym	bol		Series	

(2)	Case	size

Terminal	electrode

For automotive application

CGA



Case size	Case size		Dimensions (Unit : mm)			
Symbol	(EIA style)	L W		Т	В		
6	CGA6	3.20±0.40	2.50±0.30	2.00±0.20	0.20 min.		
0	(CC1210)	3.20±0.40	2.50±0.50	2.50±0.30	0.20 mm.		
				0.85±0.15			
				1.10±0.20			
7	CGA7 (CC1808)	4.50±0.40	2.00±0.20	1.30±0.20	0.20 min.		
				1.60±0.20			
				2.00±0.20			
	CGA8					1.30±0.20	
0		CGA8	3.20±0.40	1.60±0.20	0.20 min		
8	(CC1812)	4.50±0.40		2.00±0.20	0.20 min.		
				2.50±0.30			
9	CGA9 (CC2220)	5.70±0.40	5.00±0.40	2.80±0.30	0.20 min.		

*As for each item, please refer to detail page on TDK web.

(3) Thickness

Thickness	Dimension(mm)	Thickness	Dimension(mm)
F	0.85	М	2.00
G	1.10	Р	2.50
K	1.30	Q	2.80
L	1.60		

(4) Voltage condition in the life test	
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* Details are shown in table1 No.16 at 7.PERFORMANCE.

Sign	Condition
1	Rated Voltage

(5) Temperature Characteristics * Details are shown in table 1 No.6 and No.7 at 7.PERFORMANCE.

(6) Rated Voltage		5	Symbol	Rated Voltage
			3 A	DC 1kV
			3 D	DC 2kV
			3 F	DC 3kV
(7) Rated Capacitance Stated in three digits and in units of pico farac		mple) s	Symbol	Rated Capacitance
The first and second digits identify the first an	,		101	100 pF
second significant figures of the capacitance, third digit identifies the multiplier.			222	2,200 pF
(8) Capacitance tolerance	Symbol	Tolera	ance	Capacitance
	F	± 1	pF	10pF
	J	± 5	5 %	
K ±)%	Over 10pF
	М	± 20)%	
			•	
		-		

(9) Packaging	Symbol	Packaging
	В	Bulk
	Т	Taping

(10) TDK internal code

2. COMBINATION OF RATED CAPACITANCE AND TOLERANCE

Class	Temperature Characteristics	Capacitar	nce tolerance	Rated capacitance
4	<u> </u>	10pF	F (±1 pF)	10
I	C0G	Over 10pF K (± 10 %)		E – 12 series
2	X7R	K (± 10 %) M (± 20 %)		E – 3 series

Capacitance Step in E series

E series	Capacitance Step											
E- 3	1.0			2.2				4.7				
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2

3. OPERATING TEMPERATURE RANGE

T.C.	Min. operating Temperature	Max. operating Temperature	Reference Temperature
C0G	-55°C	125°C	25°C
X7R	-55°C	125°C	25°C

4. STORING CONDITION AND TERM

Storing temperature	Storing humidity	Storing term		
5~40°C	20~70%RH	Within 6 months upon receipt.		

5. P.C. BOARD

When mounting on an aluminum substrate, the ceramic chip capacitor. Capacitors are more likely to be affected by heat stress from the substrate. Please inquire separate specification when mounted on the substrate.

6. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.

7. PERFORMANCE

Table 1

			1		Table T	-				
No.	Item	1		Pei	formance		Test o	r inspec	tion m	nethod
1	External App	earance	No defects which may affect performance.			Inspe	ct with ma	agnifying	g glas	s (3×).
2	Insulation Re	esistance	10,000M	Ω min			uring volta je applica			
3	Voltage Proc	of		n brea	voltage without kdown or other	Voltag	voltage : je applica je/dischai	tion tim	e : 1s	-
4	Capacitance		Within th	e spe	cified tolerance.		ss 1》 pacitance	Measu freque		Measuring voltage
						an	000pF d under Over 000pF	1MHz± 1kHz±		0.5~5 Vrms.
						« Cla	•			<u> </u>
						« <u>ora</u>	Measuri frequend			leasuring voltage
						1kHz±10%)%	1.0±0.2Vrms	
5	Q Dissipation Factor	Class1 Class2	Please re web.	efer to	detail page on TDK	See N condit	lo.4 in thi ion.	s table f	or me	easuring
6		Temperature Characteristics of Capacitance			Temperature coefficient shall be calculated based on values at 25°C and 85°C temperature.					
			C0G Capaci drift	tance	0 ± 30 Within $\pm 0.2\%$ or ± 0.05 pF, whichever larger.		uring tem)°C and -:		e belo	w 25°C shall
7	7 Temperature Characteristics of Capacitance (Class2)		Characteristics Capacitance Change (%)		nce Change (%)	Capacitance shall be measured by the steps shown in the following table after				
				No vo	oltage applied	thermal equilibrium is obtained for each step.				
			X7R : ± 15		7R : ± 15	∆C be	ΔC be calculated ref. STEP3 reading			<u>·</u> _
			—				Step	ſem		ure(°C)
							1		25 ±	
							2		-55 ±	
							3		25 ±	<u> </u>
							4		125 ±	
							measurii ur sales r			ease contact

(continued)

No.	lt	em	Performance	Test or inspection method
8	Robustness of Terminations		No sign of termination coming off, breakage of ceramic, or other abnormal signs.	Reflow solder the capacitors on a P.C.Board shown in Appendix 2. Apply a pushing force gradually at the center of a specimen in a horizontal direction of P.C.board. Pushing force : 17.7N Holding time : 10±1s.
9	Bending	External appearance	No mechanical damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1. (1mm is applied for 1.30mm or thinner thickness of Class2 items.) $50 \xrightarrow{20}{}$ F R230 $45 \xrightarrow{45}{}$ (Unit : mm)
10	Solderabilit	y	New solder to cover over 75% of termination. 25% may have pin holes or rough spots but not concentrated in one spot. Ceramic surface of A sections shall not be exposed due to melting or shifting of termination material.	Solder :Sn-3.0Ag-0.5CuFlux :Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution.Solder temp. :245±5°CDwell time :3±0.3s.(Sn-3.0Ag-0.5Cu)SolderUntil both terminations position :are completely soaked.

(continued)

No.	It	em			ormance	Test c	or inspection method		
11	Resistance to solder heat	External appearance	terminatio	ons sha	llowed and all be covered at new solder.	Solder : Flux :	Sn-3.0Ag-0.5Cu Isopropyl alcohol (JIS K		
		Capacitance	Characte	eristics	Change from the value before test		8839) Rosin (JIS K 5902) 25% solid solution.		
			Class1	C0G	± 2.5 %	Solder temp.	260±5°C		
			Class2	X7R	± 7.5 %	Dwell time :	10±1s.		
		Q (Class1)	Meet the	initial s	spec.	Solder position :	Until both terminations are completely soaked.		
		D.F. (Class2)	Meet the	initial s	spec.	 Pre-heating : Temp. — 110~140°C Time — 30~60s. Leave the capacitors in ambient condition for Class 1 : 6~24h Class 2 : 24±2h before measurement. 			
		Insulation Resistance	Meet the	initial s	spec.				
		Voltage proof	No insula other dan		eakdown or				
12	Vibration	External appearance	No mech	anical	damage.		Applied force : 5G max. Frequency : 10~2,000Hz		
		Capacitance	Characte	eristics	Change from the value before test	Cycle : 12 cy	g sweep time : 20 min. cles in each 3 mutually		
			Class1	C0G	± 2.5 %	perpe	endicular directions.		
			Class2	X7R	± 7.5 %	Reflow solder the capacitors on a P.C.Board shown in Appendix 2 before			
		Q (Class1)	Meet the	initial s	spec.	testing.			
		D.F. (Class2)	Meet the	initial s	spec.				

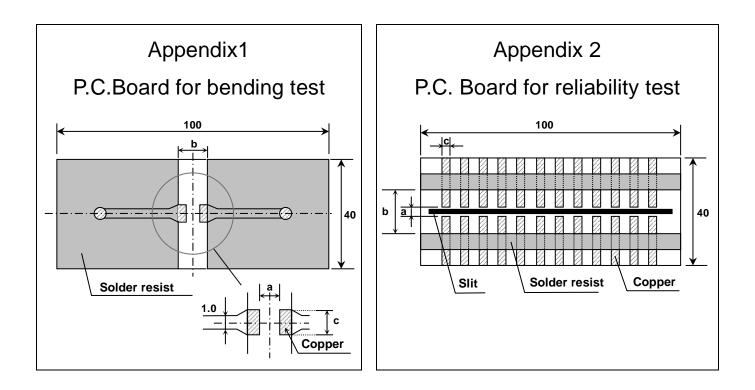
- 1	(continued)	
. (continueur	

No.	lte	em		Perf	ormance		Test or inspection m	nethod		
13	Temperature cycle	External appearance	No mechanical damage.			step1 tl	Expose the capacitors in the condition step1 through step 4 listed in the following table.			
		Capacitance	Charact	eristics	Change from the value before test		cycle : 1,000 cycles			
			Class1	C0G	Please contact	Step	Temperature(°C)	Time (min.		
			Class2	X7R	with our sales representative.	1	-55 ± 3	30 ± 3		
			Ud552			2	Ambient Temp.	2 ~ 5		
		Q	Meet the	initial	spec.	3	125 ± 2	30 ± 2		
		(Class1)				4	Ambient Temp.	2 ~ 5		
		D.F. (Class2)	Meet the	initial	spec.	Leave t	the capacitors in an	nbient		
		Insulation Resistance	Meet the initial spec.			Class 1 : 6~24h Class 2 : 24±2h before measurement.				
		Voltage proof	No insula other dar		reakdown or		Reflow solder the capacitors on a P.C.Board shown in Appendix 2 before testing.			
14	Moisture Resistance	External appearance	No mechanical damage.			Test hu	np.:40±2°C midity:90~95%RH			
	(Steady State)	Capacitance	Charac	teristics	Change from the value before test		ne:500 +24,0h the capacitors in an	nbient		
			Class1	COG	Please contact with our sales	conditio				
			Class2	X7R	representative.	Class 2	2 : 24±2h before me	asurement.		
		Q					solder the capacitor			
		(Class1)	· ·	itance	Q	testing.	ard shown in Appen			
				nd over						
			under	nd over 30pF	275+5/2×C min.					
					citance (pF)	_]			
		D.F. (Class2)	200% of	initial s	spec. max.					
		Insulation Resistance	1,000MΩ min.							

(continued)

No.	Ite	em	Per	formance	Test or inspection method		
15	Moisture Resistance	External appearance	No mechanica	I damage.	Test temp. : 85±2°C Test humidity : 85%RH Applied voltage : 1kV DC		
		Capacitance	Characteristics	Change from the value before test	Test time : 1,000 +48,0h		
			Class1 COG	Please contact with our sales	Charge/discharge current : 50mA or lower		
			Class2 X7R		Leave the capacitors in ambient condition for Class 1 : 6~24h		
		0			Class 2 : $24\pm 2h$ before measurement.		
		Q (Class1)	Capacitance	e Q			
		(,	30pF and ove	r 200 min.	Reflow solder the capacitors on a P.C.Board shown in Appendix2 before		
			Under 30pF	100+10/3×C min.	testing.		
			C : Rated capa	acitance (pF)	Initial value setting (only for class 2)		
		D.F. (Class2)	200% of initial	spec. max.	Voltage conditioning 《After voltage treat the capacitors under testing temperature and voltage for 1 hour,》		
		Insulation Resistance	500MΩ min.		leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value.		
16	Life	External appearance	No mechanica	l damage.	Test temp. : 125±2°C Applied voltage : Please contact with our sales representative.		
		Capacitance	Characteristic	Change from the value before test	Test time : 1,000 +48,0h		
			Class1 COG	Please contact with our sales	Charge/discharge current : 50mA or lower		
			Class2 X7R	representative.	Leave the capacitors in ambient condition for		
		Q			Class 1 : 6~24h		
		(Class1)	Capacitanc	e Q	Class 2 : 24±2h before measurement.		
			30pF and ove		Reflow solder the capacitors on a		
			10pF and o under 30pF	275+5/2×C min.	P.C.Board shown in Appendix2 before testing.		
			C : Rated capa	acitance (pF)	laitial value estting (anh fan alage 0)		
		D.F. (Class2)	200% of initial	spec. max.	 Initial value setting (only for class 2) Voltage conditioning 《After voltage treat the capacitors under testing 		
	Insulation 1,000MΩ min. Resistance			temperature and voltage for 1 hour, leave the capacitors in ambient condition for 24±2h before			
					measurement. Use this measurement for initial value.		

*As for the initial measurement of capacitors (Class2) on number 7,11,12,13 and 14 leave capacitors at 150 0,-10°C for 1 hour and measure the value after leaving capacitors for 24±2h in ambient condition.



(Unit : mm)

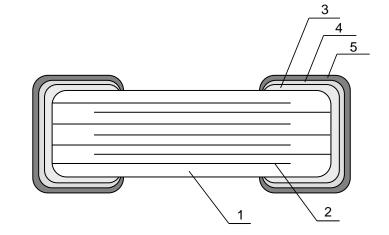
Symbol		Dimensions	
Case size	а	b	С
CGA6 (CC1210)	2.2	5.0	2.9
CGA7 (CC1808)	3.5	7.0	2.5
CGA8 (CC1812)	3.5	7.0	3.7
CGA9 (CC2220)	4.5	8.0	5.6

- 1. Material : Glass Epoxy(As per JIS C6484 GE4)
- 2. Thickness : 1.6mm

Copp

Copper(Thickness:0.035mm) Solder resist

8. INSIDE STRUCTURE AND MATERIAL



No	NAME	MATE	RIAL			
No.	NAME	Class1	Class2			
1	Dielectric	CaZrO₃	BaTiO₃			
2	Electrode	Nicke	l (Ni)			
3		Сорре	r (Cu)			
4	Termination	Nicke	l (Ni)			
5		Tin (Sn)				

9. PACKAGING

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

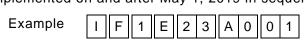
- 9.1 Total number of components in a plastic bag for bulk packaging : 1000pcs
- 9.2 Tape packaging is as per 13. TAPE PACKAGING SPECIFICATION.
 - 1) Inspection No.
 - 2) TDK P/N
 - 3) Customer's P/N
 - 4) Quantity

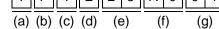
*Composition of Inspection No.

Example
$$\underbrace{F}_{(a)} \underbrace{1}_{(b)} \underbrace{A}_{(c)} - \underbrace{23}_{(d)} - \underbrace{001}_{(e)}$$

- (a) Line code
- (b) Last digit of the year
- (c) Month and A for January and B for February and so on. (Skip I)
- (d) Inspection Date of the month.
- (e) Serial No. of the day

*Composition of new Inspection No. (Implemented on and after May 1, 2019 in sequence)





- (a) Prefix
- (b) Line code
- (c) Last digit of the year
- (d) Month and A for January and B for February and so on. (Skip I)
- (e) Inspection Date of the month.
- (f) Serial No. of the day(00 ~ ZZ)
- (g) Suffix(00 ~ ZZ)
- * It was shifted to the new inspection No. on and after May 2019, but the implementation timing may be different depending on shipment bases.

Until the shift is completed, either current or new composition of inspection No. will be applied.

10. RECOMMENDATION

It is recommended to provide a slit (about 1mm wide) in the board under the components to improve washing Flux. And please make sure to dry detergent up completely before.

It is recommended to use activated flux (Chlorine content : less than 0.1wt%) such Rosin due to high voltage usage.

11. SOLDERING CONDITION

Reflow soldering only.

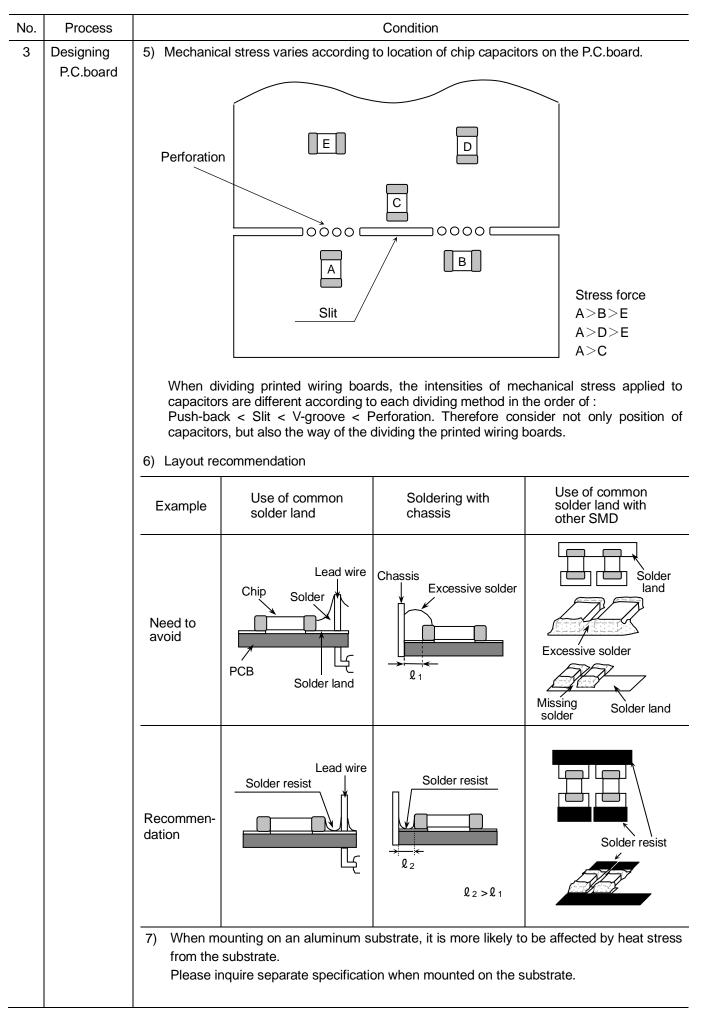
12. CAUTION

No.	Process	Condition
1	Operating	1-1. Storage, Use
·	Condition (Storage, Use, Transportation)	The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. JIS C 60721-3-1 Class 1K2 should be followed for the other climatic conditions.
		 High temperature and humidity environment may affect a capacitor's solder ability because it accelerates terminal oxidization. They also deteriorate performance of taping and packaging. Therefore, SMD capacitors shall be used within 6 months. For capacitors with terminal electrodes consisting of silver or silver-palladium which tend to become oxidized or sulfurized, use as soon as possible, such as within one month after opening the bag.
		 2) When capacitors are stored for a longer time period than 6 months, confirm the solderability of the capacitors prior to use. During storage, keep the minimum packaging unit in its original packaging without opening it. Do not deviate from the above temperature and humidity conditions even for a short term.
		 Corrosive gasses in the air or atmosphere may result in deterioration of the reliability, such as poor solderability of the terminal electrodes. Do not store capacitors where they will be exposed to corrosive gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine ammonia etc.)
		 4) Solderability and electrical performance may deteriorate due to photochemical change in the terminal electrode if stored in direct sunlight, or due to condensation from rapid changes in humidity. The capacitors especially which use resin material must be operated and stored in an environment free of dew condensation, as moisture absorption due to condensation may affect the performance.
		5) Refer to JIS C 60721-3-1, class 1K2 for other climate conditions.
		 1-2. Handling in transportation In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335C 9.2 Handling in transportation)
2	Circuit design	2-1. Operating temperature
	<u> </u>	 Upper category temperature (maximum operating temperature) is specified. It is necessary to select a capacitor whose rated temperature us higher than the operating temperature. Also, it is necessary to consider the temperature distribution in the equipment and seasonal temperature variation.
		2) Surface temperature including self heating should be below maximum operating
		temperature. Due to dielectric loss, capacitors will heat itself when AC is applied due to ESR. Especially at high frequencies, please be careful that the heat might be so extreme. Also, even if the surface temperature of the capacitor includes self-heating and is the maximum operating temperature or lower, excessive heating of the capacitor due to self-heating may cause deterioration of the characteristics and reliability of the capacitor.
		The self-heating temperature rise of the capacitor changes depending on the difference in heat radiation due to the mounting method to the device, the ambient temperature, the cooling method of the device and circuit board material and the design, etc. The load should be contained so that the self-heating temperature rise of the
		capacitor body in a natural convection environment at an ambient temperature of 25°C remain below 20°C.
		When using in a high-frequency circuit or a circuit in which a capacitor generates heat, such as when a high-frequency ripple current flows, pay attention to the above precautions. (Note that accurate measurement may not be possible with self-heating measurement when the equipment applies cooling other than natural convection such as a cooling fan.)

No.	Process	Condition					
2	Circuit design	 The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature into consideration. 					
		2-2. When overvoltage is applied					
		Applying overvoltage to a capacitor may cause dielectric breakdown and result in a short circuit. The duration until dielectric breakdown depends on the applied voltage and the ambient temperature.					
		 2-3. Operating voltage 1) Operating voltage across the terminals should be below the rated voltage. When AC and DC are super imposed, V_{0-P} must be below the rated voltage. — (1) and (2) 					
	AC or pulse with overshooting, V_{P-P} must be below the rated voltage. — (
		When the voltage is started to apply to the circuit or it is stopped applying, the irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitors within rated voltage containing these Irregular voltage.					
		Voltage (1) DC voltage (2) DC+AC voltage (3) AC voltage					
		Positional Measurement (Rated voltage) v_{0-P} v_{0-P} v_{0-P} v_{0-P}					
		Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)					
		Positional Measurement (Rated voltage)					
		 Even below the rated voltage, if repetitive high frequency AC or pulse is applied, the reliability of the capacitors may be reduced. 					
		 The effective capacitance will vary depending on applied DC and AC voltages. The capacitors should be selected and designed in taking the voltages into consideration. 					
		 Abnormal voltage (surge voltage, static electricity, pulse voltage, etc.) shall not exceed the rated voltage. 					
		5) When capacitors are used in a series connection, it is necessary to add a balancing circuit such as voltage dividing resistors in order to avoid an imbalance in the voltage applied to each capacitor.					
		2-4. Frequency When the capacitors (Class 2) are used in AC and/or pulse voltages, the capacitors may vibrate themselves and generate audible sound.					

No.	Process			Condition		
3	Designing P.C.board			r, the higher the s ak. When desigr	stress on the chip ning a P.C.board,	capacitors, determine the
		2) Avoid using con solder land for e	nmon solder lanc each terminations	l for multiple term s.	inations and pro	vide individual
		3) Size and recom	mended land din	nensions.		
			Chip capacitors			Solder resist
		Reflow solder				(mm)
		Case size Symbol	CGA6 (CC1210)	CGA7 (CC1808)	CGA8 (CC1812)	CGA9 (CC2220)
		A	2.0 ~ 2.4	3.1 ~ 3.7	3.1 ~ 3.7	4.1 ~ 4.8
		В	1.0 ~ 1.2	1.2 ~ 1.4	1.2 ~ 1.4	1.2 ~ 1.4
		C	1.9 ~ 2.5	1.5 ~ 2.0	2.4 ~ 3.2	4.0 ~ 5.0
		D	1.0 ~ 1.3	1.0 ~ 1.3	1.0 ~ 1.3	1.0 ~ 1.3
			o improve washi			e board under th o dry detergent u
			nded to use low a e to high voltage		hlorine content :	less than 0.1wt%

No.	Process		Condition	
3	Designing P.C.board	5) Recommended	d chip capacitors layout is as follo	wing.
			Disadvantage against bending stress	Advantage against bending stress
		Mounting face	Perforation or slit	Perforation or slit
		Chip arrangement (Direction)	Mount perpendicularly to perforation or slit	Mount in parallel with perforation or slit
		Distance from slit	Closer to slit is higher stress $label{eq:loser}$ $label{eq:loser}$ $(l_1 < l_2)$	Away from slit is less stress l_2 l_2 l_1 $(l_1 < l_2)$
			1	<u> </u>



No.	Process		Condition	
4	Mounting	 capacitors to rest 1) Adjust the botto surface and not 2) Adjust the mout 3) To minimize the 	ead is adjusted too low, it may in ult in cracking. Please take followin or dead center of the mounting he press it. nting head pressure to be 1 to 3N e impact energy from mounting hea e bottom side of the P.C.board.	ead to reach on the P.C.board of static weight.
			Not recommended	Recommended
		Single sided mounting	Crack	A support pin is not to be underneath the capacitor.
		Double-sides mounting	Solder peeling Crack	Support pin
		to cause crack. P	ng jaw is worn out, it may give me Please control the close up dimens preventive maintenance and repla	

No.	Process		Condition				
5	Soldering	5-1. Flux selection Flux can seriously affect the performed the appropriate flux.	Flux can seriously affect the performance of capacitors. Confirm the following to select				
			 It is recommended to use a mildly activated rosin flux (less than 0.1wt% chlorine). Strong flux is not recommended. 				
		2) Excessive flux must be avoided	d. Please provide pro	per amount of flux.			
		3) When water-soluble flux is use	s necessary.				
		5-2. Recommended Reflow solderi	ing temperature profi	le			
			Reflow soldering				
		Pre	Soldering				
		Peak Temp					
		Q					
		TΔ CO TΔ					
		Tem					
		Over 60	^{J sec.} →				
	5-3. Recommended soldering peak temp and peak temp duration for Refle						
		Pb free solder is recommended,	but if Sn-37Pb must	be used, refer to below.			
		Temp./Duration	Reflow s	oldering			
		Solder	Peak temp(°C)	Duration(sec.)			
		Lead Free Solder	260 max.	10 max.			
		Sn-Pb Solder	230 max.	20 max.			
		Recommended solder compos	itions				
		Lead Free Solder : Sn-3.0Ag-					
		5-4. Avoiding thermal shock					
		1) Preheating condition					
		Soldering	Temp. (°C)				
		Reflow soldering	$\Delta T \leq 130$				
		2) Cooling condition					
		Natural cooling using air is rec	ommended. If the ch	ips are dipped into a solvent for			
		3 3 3 3 4 5					

No.	Process	Condition				
5 Soldering		5-5. Amount of solder Excessive solder will induce higher tensile force in chip capacitors when temperature changes and it may result in chip cracking. In sufficient solder may detach the capacitors from the P.C.board.				
		Excessive solder Higher tensile force in chip capacitors to cause crack				
		Adequate				
		Insufficient solder Low robustness may cause contact failure or chip capacitors come off the P.C.board.				
		 5-6. Sn-Zn solder Sn-Zn solder affects product reliability. Please contact TDK in advance when utilize Sn-Zn solder. 5-7. Countermeasure for tombstone The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especially the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering. (Refer to JEITA RCR-2335C Annex A (Informative), Recommendations to prevent the tombstone phenomenon.) 				

No.	Process		Condition				
6	Solder repairing	Solder repairing is unavoidable, refer to below.					
		(also called a "blower") rather th	possibly be reduced by using a spot heater				
		 Reworking using a spot heater capacitor compared to using a uniformly with a small heat gra stress caused by quick heating Moreover, where ultra-small ca 	 Reworking using a spot heater may suppress the occurrence of cracks in the capacitor compared to using a soldering iron. A spot heater can heat up a capacitor uniformly with a small heat gradient which leads to lower thermal stress caused by quick heating and cooling or localized heating. Moreover, where ultra-small capacitors are mounted close together on a printed circuit board, reworking with a spot heater can eliminate the risk of direct contact 				
		 2) Rework condition If the blower nozzle of a spot heater is too close to a capacitor, a crack in the capacitor may occur due to heat stress. Below are recommendations for avoiding such an occurrence. Keep more than 5mm between a capacitor and a spot heater nozzle. The blower temperature of the spot heater shall be lower than 400°C. The airflow shall be set as weak as possible. The diameter of the nozzle is recommended to be 2mm(one-outlet type). The size is standard and common. Duration of blowing hot air is recommended to be 30s or less, considering surface area of the capacitor and melting temperature of solder. The angle between the nozzle and the capacitor is recommended to be 45degrees					
		capacitors and improves opera	oldering iron, preheating reduces thermal stress on				
		Distance from nozzle	5mm and over				
		Nozzle angle	45degrees				
		Nozzle temp.	400°C and less				
		Airflow	Set as weak as possible (The airflow shall be the minimum value necessary for solder to melt in the conditions mentioned above.)				
		Nozzle diameter	ϕ 2mm (one-outlet type)				
		Blowing duration	30s and less				
		Example of recommended s	spot heater use				
			One-outlet type nozzle				
		3) Amount of solder should be su	uitable to from a proper fillet shape. nical and thermal stress on a capacitor and results				

Solder repairing	6-2. Solder repair by sol				
	6-2. Solder repair by solder iron				
	 Selection of the soldering iron tip Tip temperature of solder iron varies by its type, P.C.board material and solder land size. The higher the tip temperature, the quicker the operation. However, heat shock may cause a crack in the chip capacitors. Please make sure the tip temp. before soldering and keep the peak temp and time in accordance with following recommended condition. 				
		Manual soldering (Solder iron)			
	Temp. (°C)	Peak Temp			
		Recommended solder iron condition (Sn-Pb Solder and Lead Free Solder)Temp. (°C)Duration (sec.)Wattage (W)Shape (mm)			
	280 max.	3 max.	20 max.	Ø 3.0 max.	
	* Please preheat the chi	p capacitors with the	condition in 6-3 to a	avoid the thermal shock.	
		-			
	3) It is not recommended to reuse dismounted capacitors.				
	6-3. Avoiding thermal sh	lock			
	Preheating condition	۱ 			
	Solder	ing	Temp. (°C)		
	Manual so		∆T ≦ 130		
		Iand size. The high heat shock may can Please make sure to time in accordance Peak Temp. (°C) 280 max. * Please preheat the chi 2) Direct contact of the cause crack. Do no 3) It is not recommend 6-3. Avoiding thermal sh Preheating condition Solder	Iand size. The higher the tip temperatur heat shock may cause a crack in the ch Please make sure the tip temp. before s time in accordance with following recom Manual s (Solder Image: Solder strength Image: Strength Image: Strength Image: Strength Image: Strengt Image: St	Iand size. The higher the tip temperature, the quicker the opheat shock may cause a crack in the chip capacitors. Please make sure the tip temp. before soldering and keep the time in accordance with following recommended condition. Manual soldering (Solder iron) Peak Image: the tip temp. Image: temp. Image	

No.	Process	Condition
7	Cleaning	1) If an unsuitable cleaning fluid is used, flux residue or some foreign articles may stick to chip capacitors surface to deteriorate especially the insulation resistance.
		2) If cleaning condition is not suitable, it may damage the chip capacitors.
		2)-1. Insufficient washing
		(1) Terminal electrodes may corrode by Halogen in the flux.
		(2) Halogen in the flux may adhere on the surface of capacitors, and lower the insulation resistance.
		(3) Water soluble flux has higher tendency to have above mentioned problems (1) and (2).
		2)-2. Excessive washing
		When ultrasonic cleaning is used, excessively high ultrasonic energy output can affect the connection between the ceramic chip capacitor's body and the terminal electrode. To avoid this, following is the recommended condition.
		Power : 20 W/ 2 max.
		Frequency : 40 kHz max.
		Washing time : 5 minutes max.
		2)-3. If the cleaning fluid is contaminated, density of Halogen increases, and it may bring the same result as insufficient cleaning.
8	Coating and	1) When the P.C.board is coated, please verify the quality influence on the product.
	molding of the P.C.board	 Please verify carefully that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitors.
		3) Please verify the curing temperature.
9	Handling after chip mounted	 Please pay attention not to bend or distort the P.C.board after soldering in handling otherwise the chip capacitors may crack.
		Bend Twist

		1				
No. 9	Process	0) Deinste die sine vit hier and	Condition	and not have been all have been all		
 9 Handling after chip mounted Caution 2) Printed circuit board cropping should not be carried o proper tooling. Printed circuit board cropping should be cropping jig as shown in the following figure or a be prevent inducing mechanical stress on the board. 				r a board cropping apparatu	oard	
		 (1)Example of a board cropping jig Recommended example: The board should be pushed from the back si close to the cropping jig so that the board is not bent and the stress applied the capacitor is compressive. Unrecommended example: If the pushing point is far from the cropping jig a the pushing direction is from the front side of the board, large tensile stress applied to the capacitor, which may cause cracks. 				
		Outline of jig	Recommended	Unrecommended		
		board	inted cuit ard Load point Groove	of Load point Printed circuit board V-groove	`	
		(2)Example of a board				
		-		g machine is shown below. Th another along the lines with t		
		•	d circuit board when cro ample: Misalignment o	pping the board. f blade position between top	and	
				ades may cause a crack in		
			achina	Drinciple of operation		
V-gro			Top Drinted eiroui			
			Print	Cross-section diagram ed circuit board Top blade		
				V-groove Bottom blac	de	
		Recommended		ommended		
		Top blade		t-right Front-rear ignment misalignment		
		Board	Top blade Top	blade Top blade		
		Bottom blade	Bottom blade Botto	m blade Bottom blade		

No.	Process		Condition		
9	Handling after chip mounted Caution	3) When functional check of the P.C.board is performed, check pin pressure tends to be adjusted higher for fear of loose contact. But if the pressure is excessive and bend the P.C.board, it may crack the chip capacitors or peel the terminations off. Please adjust the check pins not to bend the P.C.board.			
		Item	Not recommended	Recommended	
		Board bending	Termination peeling Check pin	Support pin	
10	Handling of loose chip capacitors	 1) If dropped the chip capacitors may crack. Once dropped do not use it. Especia the large case sized chip capacitors are tendency to have cracks easily, so ple handle with care. Floor 2) Piling the P.C.board after mounting for storage or handling, the corner of the P. board may hit the chip capacitors of another board to cause crack. 		ency to have cracks easily, so please	
11	Capacitance aging	The capacitors (Class 2) have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well.			
12	Estimated life and estimated failure rate of capacitors	As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335C Annex F (Informative) Calculation of the estimated lifetime and the estimated failure rate (Voltage acceleration coefficient : 3 multiplication rule, Temperature acceleration coefficient : 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage bu they will not be guaranteed.		uation described in JEITA the estimated lifetime and the ficient : 3 multiplication rule,	

No.	Process	Condition
13	Caution during operation of equipment	 A capacitor shall not be touched directly with bare hands during operation in order to avoid electric shock. Electric energy held by the capacitor may be discharged through the human body when touched with a bare hand. Even when the equipment is off, a capacitor may stay charged. The capacitor should be handled after being completely discharged using a resistor.
		2) The terminals of a capacitor shall not be short-circuited by any accidental contact with a conductive object. A capacitor shall not be exposed to a conductive liquid such as an acid or alkali solution. A conductive object or liquid, such as acid and alkali, between the terminals may lead to the breakdown of a capacitor due to short circuit
		 3) Confirm that the environment to which the equipment will be exposed during transportation and operation meets the specified conditions. Do not to use the equipment in the following environments. (1) Environment where a capacitor is spattered with water or oil (2) Environment where a capacitor is exposed to direct sunlight (3) Environment where a capacitor is exposed to Ozone, ultraviolet rays or radiation (4) Environment where a capacitor exposed to corrosive gas(e.g. hydrogen sulfide, sulfur dioxide, chlorine. ammonia gas etc.) (5) Environment where a capacitor exposed to vibration or mechanical shock exceeding the specified limits. (6) Atmosphere change with causes condensation
14	Others	The product listed in this specification is intended for use in automotive applications under-normal operation and usage conditions.
		The product is not designed or warranted to meet the requirements of application listed below, whose performance and/or quality requires a more stringent level of safety or reliability, or whose failure, malfunction or defect could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us.
		 (1) Aerospace/Aviation equipment (2) Transportation equipment (electric trains, ships etc.) (3) Medical equipment (Excepting Pharmaceutical Affairs Law classification Class1, 2) (4) Power-generation control equipment (5) Atomic energy-related equipment (6) Seabed equipment (7) Transportation control equipment (8) Public information-processing equipment (9) Military equipment (10) Electric heating apparatus, burning equipment (11) Disaster prevention/crime prevention equipment (12) Safety equipment (13) Other applications that are not considered general-purpose applications
		When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or providing backup circuits in your equipment. In addition, although the product listed in this specification is intended for use in automotive applications as described above, it is not prohibited to use for general electronic equipment, whose performance and/or quality doesn't require a more stringent level of safety or reliability, or whose failure, malfunction or defect could not cause serious damage to society, person or property. Therefore, the description of this caution will be applied, when the product is used in general electronic equipment under a normal operation and usage conditions.

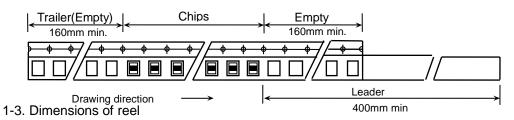
13. TAPE PACKAGING SPECIFICATION

1. CONSTRUCTION AND DIMENSION OF TAPING

1-1. Dimensions of carrier tape

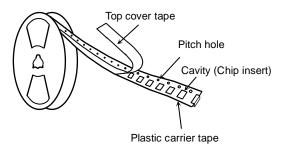
Dimensions of plastic tape shall be according to Appendix 3, 4.

1-2. Bulk part and leader of taping



Dimensions of Ø178 reel shall be according to Appendix 5, 6. Dimensions of Ø330 reel shall be according to Appendix 7, 8.

1-4. Structure of taping



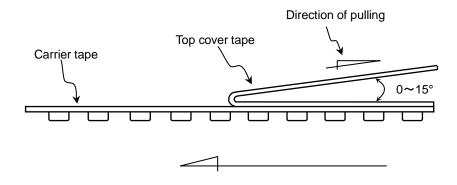
2. CHIP QUANTITY

Please refer to detail page on TDK web.

3. PERFORMANCE SPECIFICATIONS

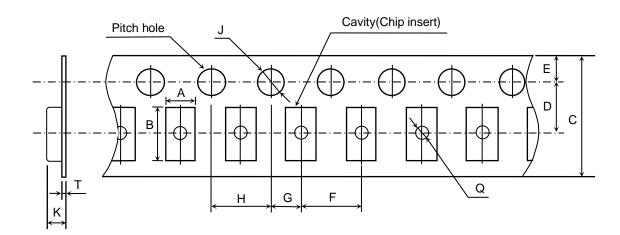
3-1. Fixing peeling strength (top cover tape)

0.05N < Peeling strength < 0.7N



- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. When removing the cover tape, there shall not be difficulties by unfitting clearance gap, burrs and crushes of cavities. Also the sprocket holes shall not be covered by absorbing dust into the suction nozzle.

Appendix 3 Plastic Tape

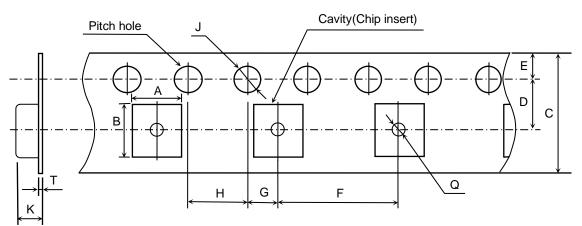


						(Unit : mm)
Symbol Case size	А	В	С	D	Е	F
CGA6 (CC1210)	(2.90)	(3.60)	8.00 ± 0.30 *12.0 ± 0.30	3.50 ± 0.05 *5.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
Symbol Case size	G	Н	J	К	Т	Q
CGA6 (CC1210)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10 0	3.40 max.	0.60 max.	Ø 0.50 min.

() Reference value. Exceptionally no hole in the cavity is applied. Please inquire if hole in cavity is mandatory. * Applied to thickness, 2.5mm products.

Appendix 4

Plastic Tape



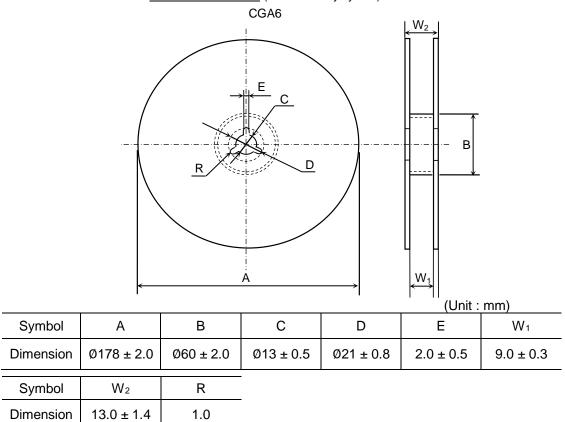
						(Unit : mm)
Symbol Case size	А	В	С	D	Е	F
CGA7 (CC1808)	(2.50)	(5.10)		5.50 ± 0.05	1.75 ± 0.10	8.00 ± 0.10
CGA8 (CC1812)	(3.60)	(5.20)	12.0 ± 0.30			
CGA9 (CC2220)	(5.40)	(6.10)				
Symbol Case size	G	Н	J	К	Т	Q
CGA7 (CC1808)						
CGA8 (CC1812)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10 0	6.50 max.	0.60 max.	Ø 1.50 min.
CGA9 (CC2220)						

() Reference value.

Exceptionally no hole in the cavity is applied. Please inquire if hole in cavity is mandatory.

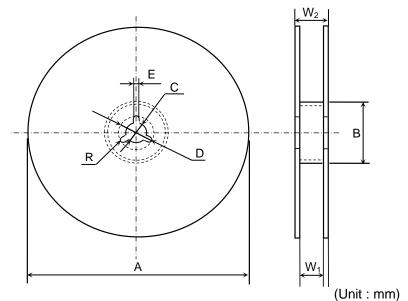
Appendix 5

Dimensions of reel (Material : Polystyrene)



Appendix 6

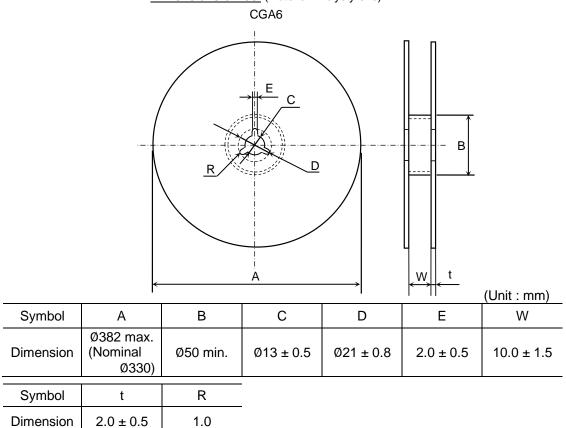
<u>Dimensions of reel</u> (Material : Polystyrene) CGA6(2.5mm thickness products), CGA7, CGA8, CGA9



Symbol	A	В	С	D	E	W ₁
Dimension	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	13.0 ± 0.3
Symbol	W ₂	R				
Dimension	17.0 ± 1.4	1.0				

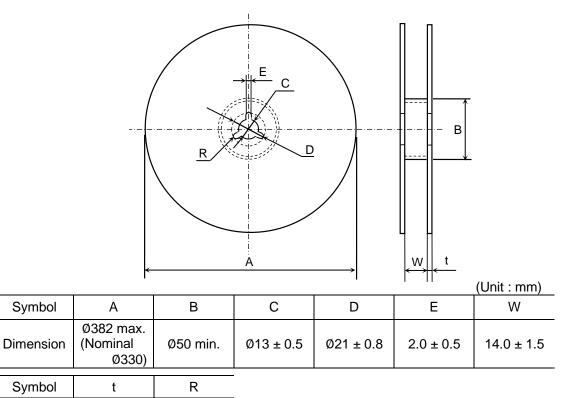
Appendix 7

Dimensions of reel (Material : Polystyrene)



Appendix 8

<u>Dimensions of reel</u> (Material : Polystyrene) CGA6(2.5mm thickness products), CGA7, CGA8, CGA9



1.0

Dimension

 2.0 ± 0.5